

# N-Channel 650V (D-S) Power MOSFET

| PRODUCT SUMMA                              | RY                      |      |
|--|-------------------------|------|
| V <sub>DS</sub> (V) at T <sub>J</sub> max. | 650                     | )    |
| R <sub>DS(on)</sub> max. at 25 °C (Ω)      | $V_{GS} = 10 \text{ V}$ | 0.68 |
| Q <sub>g</sub> max. (nC)                   | 43                      |      |
| Q <sub>gs</sub> (nC)                       | 5                       |      |
| Q <sub>gd</sub> (nC)                       | 22                      |      |
| Configuration                              | Sing                    | le   |

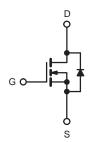
#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted) |                         |   |                                   |             |      |  |  |
|--|-------------------------|---|-----------------------------------|-------------|------|--|--|
| PARAMETER  |                         |   | SYMBOL                            | LIMIT       | UNIT |  |  |
| Drain-Source Voltage   |                         |   | $V_{DS}$                          | 650         | V    |  |  |
| Gate-Source Voltage  |                         |   | $V_{GS}$                          | ± 30        | 7 v  |  |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C)                               | V <sub>GS</sub> at 10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ | I <sub>D</sub>                    | 12          |      |  |  |
|  | VGS at 10 V             | T <sub>C</sub> = 100 °C   |                                   | 9.4         | Α    |  |  |
| Pulsed Drain Current <sup>a</sup>  |                         |   | I <sub>DM</sub>                   | 45          |      |  |  |
| Linear Derating Factor   |                         |   |                                   | 3.6         | W/°C |  |  |
| Single Pulse Avalanche Energy b  |                         |   | E <sub>AS</sub>                   | 290         | mJ   |  |  |
| Maximum Power Dissipation  |                         |   | $P_{D}$                           | 106 /34     | W    |  |  |
| Operating Junction and Storage Temperature Range                                 |                         |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C   |  |  |
| Drain-Source Voltage Slope   | T <sub>J</sub> = 125 °C |   | d)//d+                            | 15          | V/ns |  |  |
| Reverse Diode dV/dt d  |                         |   | dV/dt                             | 4.1         | v/ns |  |  |
| Soldering Recommendations (Peak Temperature) c                                   | for                     | 10 s  |                                   | 300         | °C   |  |  |

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 4.5 A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



| THERMAL RESISTANCE RATI          | NGS               |      |      |       |
|----------------------------------|-------------------|------|------|-------|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT  |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 60   | °C/W  |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$        | -    | 0.8  | G/ VV |

| PARAMETER   | SYMBOL                | TEST CONDITIONS   |   | MIN. | TYP. | MAX.  | UNIT |
|---|-----------------------|---|---|------|------|-------|------|
| Static  |                       |   |   | -    |      |       | •    |
| Drain-Source Breakdown Voltage                            | V <sub>DS</sub>       | V <sub>GS</sub> :   | = 0 V, I <sub>D</sub> = 250 μA  | 650  | -    | -     | V    |
| V <sub>DS</sub> Temperature Coefficient                   | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA   | -    | 0.75 | -     | V/°C |
| Gate-Source Threshold Voltage (N)                         | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$  |      | -    | 5     | V    |
|   |                       | V <sub>GS</sub> = ± 20 V  |   | -    | -    | ± 100 | nA   |
| Gate-Source Leakage                                       | I <sub>GSS</sub>      | V <sub>GS</sub> = ± 30 V  |   | -    | -    | ± 1   | μΑ   |
|   |                       |   | = 650 V, V <sub>GS</sub> = 0 V  | -    | -    | 1     |      |
| Zero Gate Voltage Drain Current                           | $I_{DSS}$             |   | V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V<br>V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C |      | -    | 10    | μΑ   |
| Drain-Source On-State Resistance                          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 8 A  | -    | 0.65 | -     | Ω    |
| Forward Transconductance                                  | 9fs                   | V <sub>DS</sub> = 30 V, I <sub>D</sub> = 8 A  |   | -    | 16   | -     | S    |
| Dynamic   |                       |   |   |      |      | ·     |      |
| Input Capacitance   | C <sub>iss</sub>      | $V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ $f = 1 \text{ MHz}$                                       |   | -    | 1600 | -     | pF   |
| Output Capacitance  | Coss                  |   |   | -    | 300  | -     |      |
| Reverse Transfer Capacitance                              | C <sub>rss</sub>      |   |   | -    | 200  | -     |      |
| Effective Output Capacitance, Energy Related <sup>a</sup> | C <sub>o(er)</sub>    | V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V   |   | -    | 63   | -     |      |
| Effective Output Capacitance, Time Related <sup>b</sup>   | C <sub>o(tr)</sub>    |   |   | -    | 213  | -     |      |
| Total Gate Charge   | $Q_g$                 |   |   | -    | 43   | 96    |      |
| Gate-Source Charge  | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V  | $I_D = 8 A, V_{DS} = 520 V$   | -    | 5    | -     | nC   |
| Gate-Drain Charge   | Q <sub>gd</sub>       |   |   | -    | 22   | -     |      |
| Turn-On Delay Time  | t <sub>d(on)</sub>    | $V_{DD} = 520 \text{ V}, I_D = 8 \text{ A}, V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$                        |   | -    | 13   | 25    | ns   |
| Rise Time   | t <sub>r</sub>        |   |   | -    | 11   | 35    |      |
| Turn-Off Delay Time                                       | t <sub>d(off)</sub>   |   |   | -    | 81   | 90    |      |
| Fall Time   | t <sub>f</sub>        |   | 1   |      | 25   | 40    |      |
| Gate Input Resistance                                     | $R_g$                 | f = 1 MHz, open drain   |   | -    | 3.5  | -     | Ω    |
| Drain-Source Body Diode Characteristic                    | S                     |   |   |      |      |       |      |
| Continuous Source-Drain Diode Current                     | I <sub>S</sub>        | MOSFET sym  | MOSFET symbol showing the   |      | -    | 15    |      |
| Pulsed Diode Forward Current                              | I <sub>SM</sub>       | integral reverse p - n junction diode   |   | -    | -    | 40    | A    |
| Diode Forward Voltage                                     | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 8 A, V <sub>GS</sub> = 0 V   |   | -    | -    | 1.5   | V    |
| Reverse Recovery Time                                     | t <sub>rr</sub>       | -   |   | -    | 345  | -     | ns   |
| Reverse Recovery Charge                                   | Q <sub>rr</sub>       | $T_J = 25 \text{ °C}, I_F = I_S = 8 \text{ A},$<br>$dI/dt = 100 \text{ A/}\mu\text{s}, V_R = 400 \text{ V}$ |   | -    | 4.5  | -     | μC   |
| Reverse Recovery Current                                  | I <sub>RRM</sub>      |   |   | _    | 35   | _     | A    |

### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

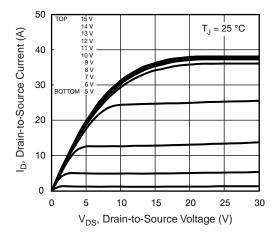


Fig. 1 - Typical Output Characteristics

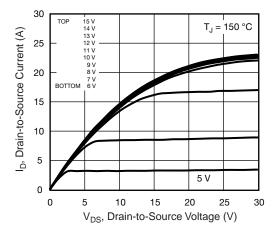


Fig. 2 - Typical Output Characteristics

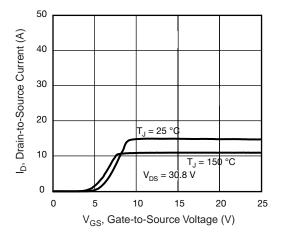


Fig. 3 - Typical Transfer Characteristics

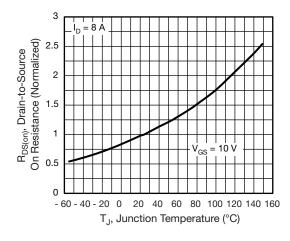


Fig. 4 - Normalized On-Resistance vs. Temperature

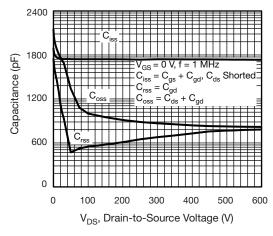


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

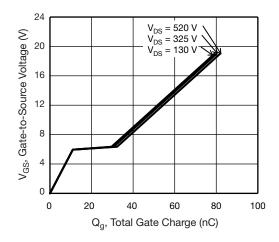


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



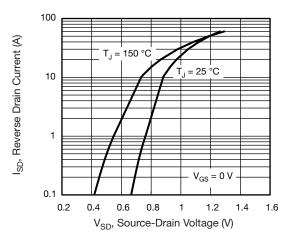


Fig. 7 - Typical Source-Drain Diode Forward Voltage

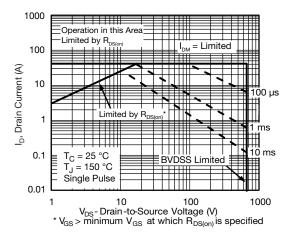


Fig. 8 - Maximum Safe Operating Area

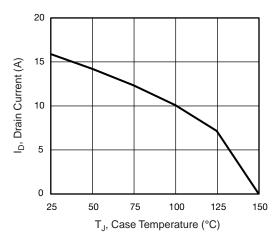


Fig. 9 - Maximum Drain Current vs. Case Temperature

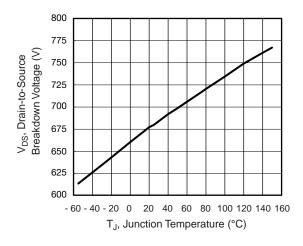


Fig. 10 - Temperature vs. Drain-to-Source Voltage

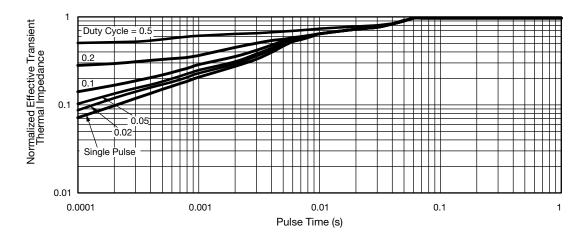


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



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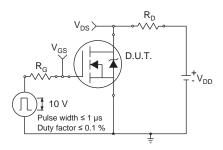


Fig. 12 - Switching Time Test Circuit

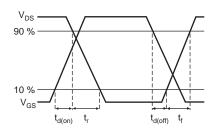


Fig. 13 - Switching Time Waveforms

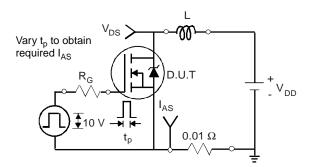


Fig. 14 - Unclamped Inductive Test Circuit

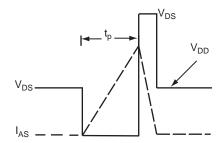


Fig. 15 - Unclamped Inductive Waveforms

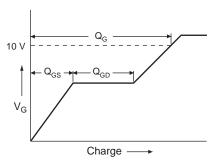


Fig. 16 - Basic Gate Charge Waveform

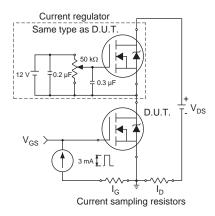
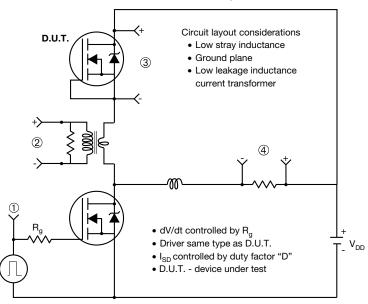


Fig. 17 - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



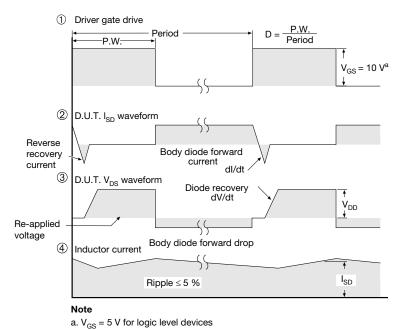
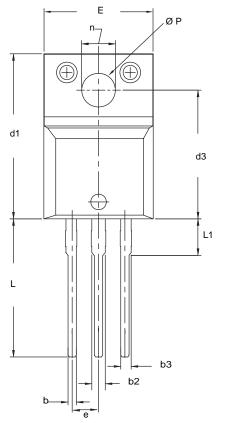
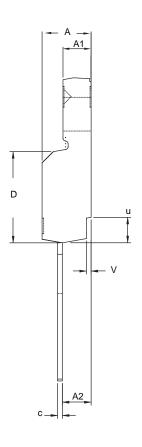


Fig. 18 - For N-Channel



## **TO-220 FULLPAK (HIGH VOLTAGE)**





| DIM. | MILLIM | IETERS | INCHES |       |
|------|--------|--------|--------|-------|
|      | MIN.   | MAX.   | MIN.   | MAX.  |
| Α    | 4.570  | 4.830  | 0.180  | 0.190 |
| A1   | 2.570  | 2.830  | 0.101  | 0.111 |
| A2   | 2.510  | 2.850  | 0.099  | 0.112 |
| b    | 0.622  | 0.890  | 0.024  | 0.035 |
| b2   | 1.229  | 1.400  | 0.048  | 0.055 |
| b3   | 1.229  | 1.400  | 0.048  | 0.055 |
| С    | 0.440  | 0.629  | 0.017  | 0.025 |
| D    | 8.650  | 9.800  | 0.341  | 0.386 |
| d1   | 15.88  | 16.120 | 0.622  | 0.635 |
| d3   | 12.300 | 12.920 | 0.484  | 0.509 |
| E    | 10.360 | 10.630 | 0.408  | 0.419 |
| е    | 2.54   | BSC    | 0.100  | BSC   |
| L    | 13.200 | 13.730 | 0.520  | 0.541 |
| L1   | 3.100  | 3.500  | 0.122  | 0.138 |
| n    | 6.050  | 6.150  | 0.238  | 0.242 |
| ØΡ   | 3.050  | 3.450  | 0.120  | 0.136 |
| u    | 2.400  | 2.500  | 0.094  | 0.098 |
| V    | 0.400  | 0.500  | 0.016  | 0.020 |

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.
   No chipping or package damage.



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